

Low Power, 3½ Digit A/D Converter

ABSOLUTE MAXIMUM RATINGS

Supply Voltage V^+	+6V	Power Dissipation (Note 2)	1000mW
V^-	-9V	Cerdip Package	800mW
Analog Input Voltage (either input) (Note 1)	V^+ to V^-	Plastic Package	0°C to +70°C
Reference Input Voltage (either input)	V^+ to V^-	Operating Temperature Range	-65°C to +160°C
Clock Input	GND to V^+	Storage Temperature Range	+300°C
		Lead Temperature (Soldering, 60 sec.)	

Note 1: Input voltages may exceed the supply voltages, provided the input current is limited to $\pm 100\mu A$.

Note 2: Dissipation rating assumes device is mounted with all leads soldered to printed circuit board.

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS (Note 3)

PARAMETERS	CONDITIONS	MIN	TYP	MAX	UNITS
Zero Input Reading	$V_{IN} = 0.0V$ Full Scale = 200.0mV	-000.0	± 000.0	+000.0	Digital Reading
Ratiometric Reading	$V_{IN} = V_{REF}$, $V_{REF} = 100mV$	999	999/1000	1000	Digital Reading
Rollover Error (Difference in reading for equal positive and negative reading near full scale)	$-V_{IN} = +V_{IN} \approx 200.0mV$	-1	± 0.2	+1	Counts
Linearity (Max. deviation from best straight line fit)	Full Scale = 200.0mV or full scale = 2.000V	-1	± 0.2	+1	Counts
Common Mode Rejection Ratio (Note 4)	$V_{CM} = \pm 1V$, $V_{IN} = 0V$ Full Scale = 200.0mV		30		$\mu V/V$
Noise (Pk-Pk value not exceeded 95% of time)	$V_{IN} = 0V$, Full Scale = 200.0mV		15		μV
Leakage Current @ Input	$V_{IN} = 0$		1	10	pA
Zero Reading Drift	$V_{IN} = 0V$, $0^\circ < T_A < +70^\circ C$		0.2	1	$\mu V/^\circ C$
Scale Factor Temperature Coefficient	$V_{IN} = 199.0mV$, $0^\circ C < T_A < +70^\circ C$ (Ext. Ref. 0ppm/ $^\circ C$)		1	5	ppm/ $^\circ C$
V^+ Supply Current (Does not include LED current)	$V_{IN} = 0V$ (Note 5)		70	200	μA
V^- Supply Current			40		
Analog COMMON Voltage (With respect to positive supply)	250k Ω between Common and Positive Supply	2.6	3.0	3.2	V
Temp. Coeff. of Analog COMMON (with respect to Positive Supply)	250k Ω between Common and Positive Supply		80		ppm/ $^\circ C$
Segment Sinking Current (Except Pin 19) (Pin 19 only)	$V^+ = 5.0V$ Segment Voltage = 3V	5 10	8.0 16		mA
Power Dissipation Capacitance	vs. Clock Frequency		40		pF

Note 3: Unless otherwise noted, specifications apply at $T_A = 25^\circ C$, $f_{CLOCK} = 16kHz$ and are tested in the circuit of Figure 1.

Note 4: Refer to "Differential Input" discussion in the ICL7136 data sheet.

Note 5: 48kHz oscillator, Figure 2, increases current by 35 μA (typ).

Note 6: Extra capacitance of CERDIP package changes oscillator resistor value to 470k Ω or 150k Ω (1 reading/sec or 3 readings/sec).

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Low Power, 3½ Digit A/D Converter

- ◆ Low Noise
- ◆ Key Parameters Guaranteed Over Temperature
- ◆ Guaranteed Overload Recovery Time
- ◆ Negligible Hysteresis
- ◆ Increased Maximum Rating for Input Current (Note 8)
- ◆ Maxim Quality and Reliability
- ◆ Significantly Improved ESD Protection (Note 7)

ICL7137

ABSOLUTE MAXIMUM RATINGS This device conforms to the Absolute Maximum Ratings on adjacent page.

ELECTRICAL CHARACTERISTICS

Specifications below satisfy or exceed all "tested" parameters on adjacent page.
($V^+ = 9V$; $T_A = 25^\circ C$; $f_{CLOCK} = 16kHz$; test circuit - Figure 1 unless noted.)

PARAMETERS	CONDITIONS	MIN	TYP	MAX	UNITS
Zero Input Reading	$V_{IN} = 0.0V$, Full Scale = 200.0mV $T_A = 25^\circ C$ (Note 9) $0^\circ \leq T_A \leq 70^\circ C$ (Note 10)	-000.0 -000.0	± 000.0 ± 000.0	+000.0 +000.0	Digital Reading
Ratiometric Reading	$V_{IN} = V_{REF}$, $V_{REF} = 100mV$ $T_A = 25^\circ C$ (Note 9) $0^\circ \leq T_A \leq 70^\circ C$ (Note 10)	999 998	999/1000 999/1000	1000 1001	Digital Reading
Rollover Error (Difference in reading for equal positive and negative reading near Full Scale)	$-V_{IN} = +V_{IN} \approx 200mV$ $T_A = 25^\circ C$ (Note 9) $0^\circ \leq T_A \leq 70^\circ C$ (Note 10)	-1	± 0.2 ± 0.2	+1	Counts
Linearity (Max. deviation from best straight line fit)	Full Scale = 200.0mV or full scale = 2.000V	-1	± 0.2	+1	Counts
Common Mode Rejection Ratio	$V_{CM} = \pm 1V$, $V_{IN} = 0V$ Full Scale = 200.0mV	-100	± 5	+100	$\mu V/V$
Noise (Pk-Pk value not exceeded 95% of time)	$V_{IN} = 0V$ Full Scale = 200.0mV		10		μV
Input Leakage Current	$V_{IN} = 0$, $T_A = 25^\circ C$ (Note 9) $0^\circ \leq T_A \leq 70^\circ C$		1	10 200	pA
Zero Reading Drift	$V_{IN} = 0V$, $0^\circ \leq T_A \leq 70^\circ C$ (Note 9)		0.2	1	$\mu V/^\circ C$
Scale Factor Temperature Coefficient	$V_{IN} = 199.0mV$ $0^\circ \leq T_A \leq 70^\circ C$ (Ext. Ref. 0ppm/ $^\circ C$)(Note 9)		1	5	ppm/ $^\circ C$
V^+ Supply Current	$V_{IN} = 0V$ $T_A = 25^\circ C$ $0^\circ \leq T_A \leq 70^\circ C$		60	200 240	μA
V^- Supply Current	$V_{IN} = 0V$,		60	200	μA
Analog Common Voltage (with respect to Pos. supply)	250k Ω between Common & Pos. Supply	2.6	2.8	3.2	V
Temp. Coeff. of Analog Common (with respect to Pos. Supply)	250k Ω between Common & Pos. Supply		75		ppm/ $^\circ C$
Segment Sinking Current (Except Pin 19) (Pin 19 only)	$V^+ = 5.0V$ Segment Voltage = 3V	5 10	8.0 16		mA mA
Test Pin Voltage	With Respect to V^+	4	5	6	V
Overload Recovery Time (Note 11)	V_{IN} changing from $\pm 10V$ to 0V		0	1	Measurement Cycles

Note 7: All pins are designed to withstand electrostatic discharge (ESD) levels in excess of 2000V. (Test circuit per Mil. Std. 883C, Method 3015.2)

Note 8: Input voltages may exceed the supply voltage provided the input current is limited to $\pm 1mA$ (This revises Note 1 on adjacent page).

Note 9: Test condition is V_{IN} applied between the "Analog Input" pins (Figure 1).

Note 10: 1M Ω resistor is removed in Figures 1 and 2.

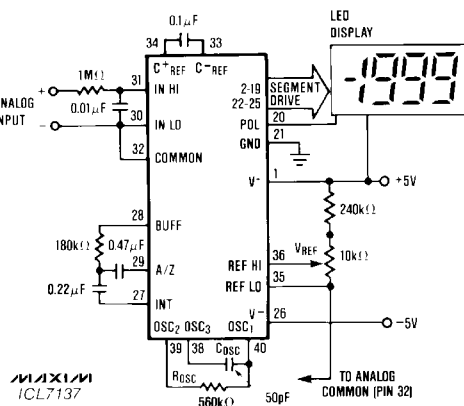
Note 11: Number of measurement cycles for display to give accurate reading.

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Detailed Description

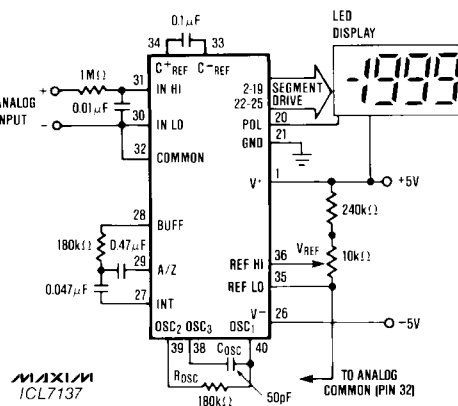
The Maxim ICL7137 3½ digit A/D converter is similar to the Maxim ICL7136 except for the LED segment driver outputs, and is similar to the ICL7107 except for much reduced power supply currents (exclusive of the LED

currents.) For a detailed product description, component value selection, and package dimensions, refer to Maxim's ICL7136 data sheets; for applications information refer to Maxim's ICL7107 data sheets.



FULL SCALE INPUT	V _{REF}
200.0 mV	100.0mV

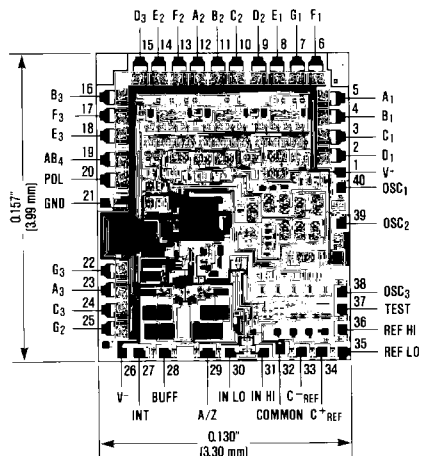
Figure 1. Maxim ICL7137 Typical Operating Circuit
Clock Frequency 16kHz (1 reading/sec)



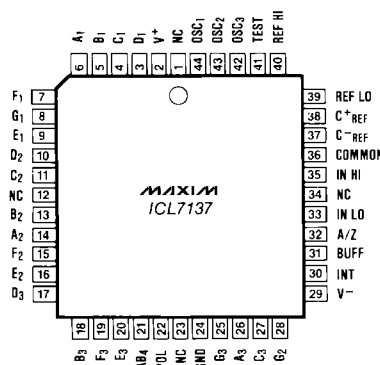
FULL SCALE INPUT	V _{REF}
200.0 mV	100.0mV

Figure 2. Maxim ICL7137 Typical Operating Circuit Clock
Frequency 48kHz (3 reading/sec)

Chip Topography



Pin Configuration



44 Lead Plastic Chip Carrier (Quad Pack)

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